1								
					Application/Control No.	Applicant(Applicant(s)/Patent Under Reexamination	
	Notice of References Cited				10/668,543	WARY, JE	WARY, JEAN-PHILIPPE	
					Examiner	Art Unit		
					Greg Bengzon	2144	Page 1 of 1	
			т = -	U.S. PA	ATENT DOCUMENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name			Classification	
*	Α	US-6,072,875 A	06-2000	Tsudik, Gene			380/270	
*	В	US-2002/0142753 A1	10-2002	Pecen et al.			455/411	
*	С	US-2002/0142805 A1	10-2002	Pecen et al.			455/558	
	D	US-						
	E	US-						
	F	US-						
	G	US-						
	Н	US-						
	ı	US-						
	J	US-						
	К	US-						
	L	US-						
	М	US-						
			1	FOREIGN	PATENT DOCUMENTS			
*		Document Number Country Code-Number-Kind Code	ent Number Date Number-Kind Code MM-YYYY Country N		Name	Classification		
	N							
	0							
├─	_							
	Р					-		
	P Q					-		
	P Q R					-		
	P Q R S							
	P Q R							
*	P Q R S				TENT DOCUMENTS			
*	P Q R S	Includ	e as applicable		TENT DOCUMENTS itle Date, Publisher, Edition or Vo	olume, Pertinent Pages	s)	
*	P Q R S T	Includ	e as applicable			olume, Pertinent Pages	5)	
*	P Q R S	Includ	e as applicable			olume, Pertinent Pages	s)	
*	P Q R S T	Includ	e as applicable		itle Date, Publisher, Edition or Vo	olume, Pertinent Pages	s)	
*	P Q R S T	Includ	e as applicable		itle Date, Publisher, Edition or Vo	olume, Pertinent Pages	s)	
*	P Q R S T	Includ	e as applicable		itle Date, Publisher, Edition or Vo	olume, Pertinent Pages	5)	
*	P Q R S T	Includ	e as applicable		itle Date, Publisher, Edition or Vo	olume, Pertinent Pages	5)	
*	P Q R S T	Includ	e as applicable		itle Date, Publisher, Edition or Vo	olume, Pertinent Pages	5)	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.